

Notice of References Cited	Application/Control No. 10/728,779		Applicant(s)/Patent Under Reexamination SILVERBROOK, KIA	
	Examiner JASON S. UHLENHAK		Art Unit 2853	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	P. DeMoor et al., "The Fabrication of Reliability Testing of Ti/TiN Heaters" SPIE Conference on Micromachining and Microfabrication Process Technology V; SPIE Vol 3874, Santa Clara, California, September 1999, pp. 284-293			
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